

Acta Crystallographica Section E

## Structure Reports

Online

ISSN 1600-5368

## 2,5-Dichlorothiophene 1,1-dioxide

Jonathan B. Briggs, Wenling Jia, Mikael D. Jazdyk and Glen P. Miller\*

Department of Chemistry and Materials Science Program, University of New Hampshire, Durham, NH 03824-3598, USA  
Correspondence e-mail: glen.miller@unh.edu

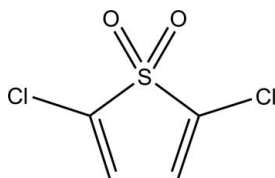
Received 28 September 2009; accepted 25 November 2009

Key indicators: single-crystal X-ray study;  $T = 296$  K; mean  $\sigma(\text{C}-\text{C}) = 0.004$  Å;  $R$  factor = 0.035;  $wR$  factor = 0.094; data-to-parameter ratio = 14.8.

The complete molecule of the title compound,  $\text{C}_4\text{H}_2\text{Cl}_2\text{O}_2\text{S}$ , is generated by crystallographic twofold symmetry, with the S atom lying on the rotation axis. In the crystal, the molecules are linked by  $\text{C}-\text{H}\cdots\text{O}$  hydrogen bonds.

### Related literature

For a related thiophene-1,1-dioxide structure, see: Douglas *et al.* (1993). For the synthetic utility and related applications of thiophene-1,1-dioxides, see: Moiseev *et al.* (2006); Nakayama & Sugihara (1999); Shul'ts *et al.* (2003); Lou *et al.* (2002).



### Experimental

#### Crystal data

$\text{C}_4\text{H}_2\text{Cl}_2\text{O}_2\text{S}$   
 $M_r = 185.02$   
Monoclinic,  $C2/c$   
 $a = 7.588$  (2) Å  
 $b = 10.584$  (3) Å  
 $c = 8.745$  (3) Å  
 $\beta = 90.275$  (9)°

$V = 702.4$  (3) Å<sup>3</sup>  
 $Z = 4$   
Mo  $K\alpha$  radiation  
 $\mu = 1.14$  mm<sup>-1</sup>  
 $T = 296$  K  
 $0.50 \times 0.40 \times 0.30$  mm

#### Data collection

Bruker SMART X2S diffractometer  
Absorption correction: multi-scan  
(*SADABS*; Bruker, 2007)  
 $T_{\min} = 0.590$ ,  $T_{\max} = 0.726$

3352 measured reflections  
622 independent reflections  
549 reflections with  $I > 2\sigma(I)$   
 $R_{\text{int}} = 0.028$

#### Refinement

$R[F^2 > 2\sigma(F^2)] = 0.035$   
 $wR(F^2) = 0.094$   
 $S = 1.12$   
622 reflections

42 parameters  
H-atom parameters constrained  
 $\Delta\rho_{\text{max}} = 0.21$  e Å<sup>-3</sup>  
 $\Delta\rho_{\text{min}} = -0.31$  e Å<sup>-3</sup>

**Table 1**

Hydrogen-bond geometry (Å, °).

$D-H\cdots A$	$D-H$	$H\cdots A$	$D\cdots A$	$D-H\cdots A$
$\text{C2}-\text{H2}\cdots\text{O1}^i$	0.93	2.52	3.367 (4)	152

Symmetry code: (i)  $x + \frac{1}{2}, y - \frac{1}{2}, z$ .

Data collection: *GIS* (Bruker, 2007); cell refinement: *SAINT* (Bruker, 2007); data reduction: *SAINT* (Bruker, 2007); program(s) used to solve structure: *SHELXS97* (Sheldrick, 2008); program(s) used to refine structure: *SHELXL97* (Sheldrick, 2008); molecular graphics: *SHELXTL* (Sheldrick, 2008); software used to prepare material for publication: *SHELXTL*.

The authors thank the National Science Foundation for support of this work through the EPSCoR Research Infrastructure Improvement program (NSF 0432060) and the Center for High-rate Nanomanufacturing (NSF EEC-0425826).

Supplementary data and figures for this paper are available from the IUCr electronic archives (Reference: FL2274).

### References

- Bruker (2007). *GIS*, *SADABS* and *SAINT*. Bruker AXS Inc., Madison, Wisconsin, USA.
- Douglas, G., Frampton, C. S. & Muir, K. W. (1993). *Acta Cryst.* **C49**, 1197–1199.
- Lou, Y., Chang, J., Jorgensen, J. & Lemal, D. M. (2002). *J. Am. Chem. Soc.* **124**, 15302–15307.
- Moiseev, A. M., Balenkova, E. S. & Nenajdenko, V. K. (2006). *Russ. Chem. Rev.* **75**, 1015–1048.
- Nakayama, J. & Sugihara, Y. (1999). *Top. Curr. Chem.* **205**, 131–195.
- Sheldrick, G. M. (2008). *Acta Cryst.* **A64**, 112–122.
- Shul'ts, E. E., Vafina, G. V., Andreev, G. N. & Tolstikov, G. A. (2003). *Kislorod I Serusoderzhashchie Geterotsiky*, **1**, 478–487.

**supplementary materials**

*Acta Cryst.* (2009). E65, o3258 [ doi:10.1107/S1600536809050776 ]

## 2,5-Dichlorothiophene 1,1-dioxide

J. B. Briggs, W. Jia, M. D. Jazdyk and G. P. Miller

### Comment

Thiophene 1,1-dioxides are important building blocks in modern organic synthesis and materials chemistry (Moiseev *et al.*, 2006). In particular, thiophene 1,1-dioxides have been utilized as Diels-Alder dienes in the construction of larger molecules (Nakayama & Sugihara, 1999) including biologically active compounds (Shul'ts *et al.*, 2003) and halogenated derivatives (Lou *et al.*, 2002). The crystal structure for tetrachlorothiophene-1,1-dioxide has also been solved (Douglas *et al.*, 1993).

Figure 1 shows the displacement ellipsoid diagram with appropriate atomic labels. Although there is only one unique H-bonding interaction in the crystal structure (Figure 2), each molecule is in fact linked to four others through symmetry related versions of this same H-bond (Table 1). Each sulfone oxygen (O1 and O1A) H-bonds to one hydrogen atom (*i.e.*, O1 – H, 2.520 (2) Å; O1A – H, 2.520 (2) Å). Likewise, each hydrogen atom H-bonds to one sulfone oxygen atom. The sulfone groups do not interdigitate with the methines of an adjacent molecule.

Each unit cell contains two complete molecules. Looking down the *a* axis of the unit cell (Figure 3), the molecules in the crystal structure are arranged head to tail (with the sulfone end being the head) in horizontal rows, with alternating rows of inverted directionality (*i.e.*, sulfone head groups pointing "right" in one row and pointing "left" in adjacent rows). Likewise, looking down the *b* axis of the unit cell (Figure 4), the molecules are arranged head to tail in vertical columns, with alternating columns of inverted directionality (*i.e.*, sulfone head groups pointing "forward" in one column and pointing "backward" in adjacent columns). The inverted directionality between adjacent rows in Figure 3 and adjacent columns in Figure 4 is further illustrated upon looking down the *c* axis (Figure 5) where one observes molecular stacks with alternating up-down orientations of the sulfone head groups. This arrangement of molecules is driven by the 4:1 H-bonding network, as previously noted. However, relatively weak  $\pi$ - $\pi$  stacking interactions also influence the arrangement of molecules, albeit to a lesser extent. Carbon atoms of closest contact in the molecular stacks are approximately 4.1 Å apart (Table 2) indicating weak  $\pi$ - $\pi$  stacking interactions (the interlayer spacing in graphite is 3.4 Å) that can only be minimally responsible for the observed ordering of molecules.

### Experimental

The title compound was prepared according to a related literature procedure (Lou *et al.*, 2002) as illustrated in Figure 6. Thus, 2,5-dichlorothiophene was oxidized in 58% yield using a mixture of trifluoroacetic anhydride, hydrogen peroxide and sulfuric acid. The title compound was purified by silica gel column chromatography (30% dichloromethane - 70% hexane eluent).  $^1\text{H}$  NMR (400 MHz,  $\text{CDCl}_3$ )  $\delta$  6.74 (s, 2H);  $^{13}\text{C}$  NMR (100 MHz,  $\text{CDCl}_3$ )  $\delta$  123.45 (CH), 131.08 (CCl). An X-ray grade crystal was obtained by slow evaporation of a dichloromethane-hexane solution.

## Figures

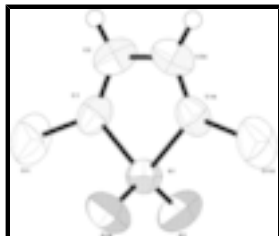


Fig. 1. The molecular structure showing the crystallographic labelling scheme and displacement ellipsoids drawn at the 50% probability level. H atoms are shown as spheres of arbitrary radii.

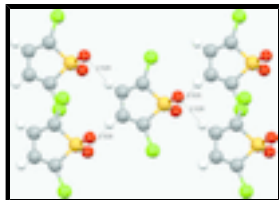


Fig. 2. Perspective view of the title compound showing sets of identical H-bonds.

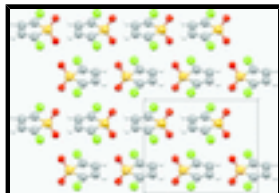


Fig. 3. Perspective view of the title compound looking down the *a* axis of the unit cell.

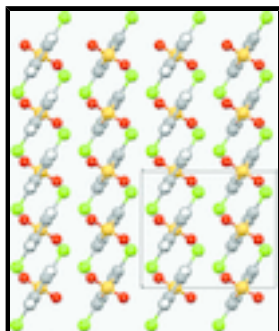


Fig. 4. Perspective view of the title compound looking down the *b* axis of the unit cell.

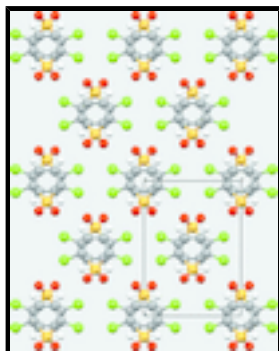


Fig. 5. Perspective view of the title compound looking down the *c* axis of the unit cell.



Fig. 6. Synthesis of the title compound, 2,5-dichlorothiophene-1,1-dioxide.

2,5-Dichlorothiophene 1,1-dioxide

*Crystal data*

$C_4H_2Cl_2O_2S$	$F(000) = 368$
$M_r = 185.02$	$D_x = 1.750 \text{ Mg m}^{-3}$
Monoclinic, $C2/c$	Mo $K\alpha$ radiation, $\lambda = 0.71073 \text{ \AA}$
Hall symbol: $-C 2yc$	Cell parameters from 1863 reflections
$a = 7.588 (2) \text{ \AA}$	$\theta = 3.3\text{--}24.8^\circ$
$b = 10.584 (3) \text{ \AA}$	$\mu = 1.14 \text{ mm}^{-1}$
$c = 8.745 (3) \text{ \AA}$	$T = 296 \text{ K}$
$\beta = 90.275 (9)^\circ$	Block, colourless
$V = 702.4 (3) \text{ \AA}^3$	$0.50 \times 0.40 \times 0.30 \text{ mm}$
$Z = 4$	

*Data collection*

Bruker SMART X2S diffractometer	622 independent reflections
Radiation source: micro-focus sealed tube doubly curved silicon crystal	549 reflections with $I > 2\sigma(I)$
$\omega$ scans	$R_{\text{int}} = 0.028$
Absorption correction: multi-scan ( <i>SADABS</i> ; Bruker, 2007)	$\theta_{\text{max}} = 25.0^\circ$ , $\theta_{\text{min}} = 3.3^\circ$
$T_{\text{min}} = 0.590$ , $T_{\text{max}} = 0.726$	$h = -9 \rightarrow 8$
3352 measured reflections	$k = -12 \rightarrow 12$
	$l = -10 \rightarrow 10$

*Refinement*

Refinement on $F^2$	Primary atom site location: structure-invariant direct methods
Least-squares matrix: full	Secondary atom site location: difference Fourier map
$R[F^2 > 2\sigma(F^2)] = 0.035$	Hydrogen site location: inferred from neighbouring sites
$wR(F^2) = 0.094$	H-atom parameters constrained
$S = 1.12$	$w = 1/[\sigma^2(F_o^2) + (0.0473P)^2 + 0.6008P]$
622 reflections	where $P = (F_o^2 + 2F_c^2)/3$
42 parameters	$(\Delta/\sigma)_{\text{max}} = 0.013$
0 restraints	$\Delta\rho_{\text{max}} = 0.21 \text{ e \AA}^{-3}$
	$\Delta\rho_{\text{min}} = -0.31 \text{ e \AA}^{-3}$

*Special details*

**Geometry.** All e.s.d.'s (except the e.s.d. in the dihedral angle between two l.s. planes) are estimated using the full covariance matrix. The cell e.s.d.'s are taken into account individually in the estimation of e.s.d.'s in distances, angles and torsion angles; correlations

## supplementary materials

between e.s.d.'s in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell e.s.d.'s is used for estimating e.s.d.'s involving l.s. planes.

**Refinement.** Refinement of  $F^2$  against ALL reflections. The weighted  $R$ -factor  $wR$  and goodness of fit  $S$  are based on  $F^2$ , conventional  $R$ -factors  $R$  are based on  $F$ , with  $F$  set to zero for negative  $F^2$ . The threshold expression of  $F^2 > \sigma(F^2)$  is used only for calculating  $R$ -factors(gt) *etc.* and is not relevant to the choice of reflections for refinement.  $R$ -factors based on  $F^2$  are statistically about twice as large as those based on  $F$ , and  $R$ -factors based on ALL data will be even larger.

### Fractional atomic coordinates and isotropic or equivalent isotropic displacement parameters ( $\text{\AA}^2$ )

	<i>x</i>	<i>y</i>	<i>z</i>	$U_{\text{iso}}^*/U_{\text{eq}}$
Cl1	0.32276 (10)	0.08665 (9)	0.07774 (10)	0.0906 (4)
S1	0.0000	0.15554 (8)	0.2500	0.0529 (3)
O1	-0.0844 (3)	0.2242 (2)	0.1299 (2)	0.0779 (6)
C1	0.1415 (3)	0.0379 (3)	0.1743 (3)	0.0582 (6)
C2	0.0827 (4)	-0.0754 (3)	0.2059 (3)	0.0677 (8)
H2	0.1398	-0.1490	0.1757	0.081*

### Atomic displacement parameters ( $\text{\AA}^2$ )

	$U^{11}$	$U^{22}$	$U^{33}$	$U^{12}$	$U^{13}$	$U^{23}$
Cl1	0.0634 (5)	0.1157 (8)	0.0932 (6)	0.0154 (4)	0.0365 (4)	0.0078 (5)
S1	0.0513 (5)	0.0506 (5)	0.0570 (5)	0.000	0.0174 (4)	0.000
O1	0.0812 (13)	0.0728 (12)	0.0799 (13)	0.0258 (11)	0.0188 (10)	0.0181 (10)
C1	0.0518 (14)	0.0674 (15)	0.0553 (14)	0.0134 (12)	0.0115 (11)	0.0005 (12)
C2	0.0788 (19)	0.0587 (15)	0.0657 (17)	0.0167 (14)	0.0042 (14)	-0.0020 (13)

### Geometric parameters ( $\text{\AA}$ , $^\circ$ )

Cl1—C1	1.698 (3)	S1—C1 <sup>i</sup>	1.774 (2)
S1—O1 <sup>i</sup>	1.427 (2)	C1—C2	1.310 (4)
S1—O1	1.427 (2)	C2—C2 <sup>i</sup>	1.476 (6)
S1—C1	1.774 (2)	C2—H2	0.9300
O1 <sup>i</sup> —S1—O1	118.8 (2)	C2—C1—C11	131.4 (2)
O1 <sup>i</sup> —S1—C1	111.19 (13)	C2—C1—S1	110.9 (2)
O1—S1—C1	110.68 (12)	C11—C1—S1	117.74 (16)
O1 <sup>i</sup> —S1—C1 <sup>i</sup>	110.68 (12)	C1—C2—C2 <sup>i</sup>	113.68 (16)
O1—S1—C1 <sup>i</sup>	111.19 (13)	C1—C2—H2	123.2
C1—S1—C1 <sup>i</sup>	90.87 (18)	C2 <sup>i</sup> —C2—H2	123.2

Symmetry codes: (i)  $-x, y, -z+1/2$ .

### Hydrogen-bond geometry ( $\text{\AA}$ , $^\circ$ )

$D-H\cdots A$	$D-H$	$H\cdots A$	$D\cdots A$	$D-H\cdots A$
C2—H2 $\cdots$ O1 <sup>ii</sup>	0.93	2.52	3.367 (4)	152

Symmetry codes: (ii)  $x+1/2, y-1/2, z$ .

**Table 2** *$\pi$ - $\pi$  stacking interaction geometry ( $\text{\AA}$ ,  $^\circ$ )*

X...Y	$\pi$ ... $\pi$
C1...C2	4.137 (4)

Fig. 1

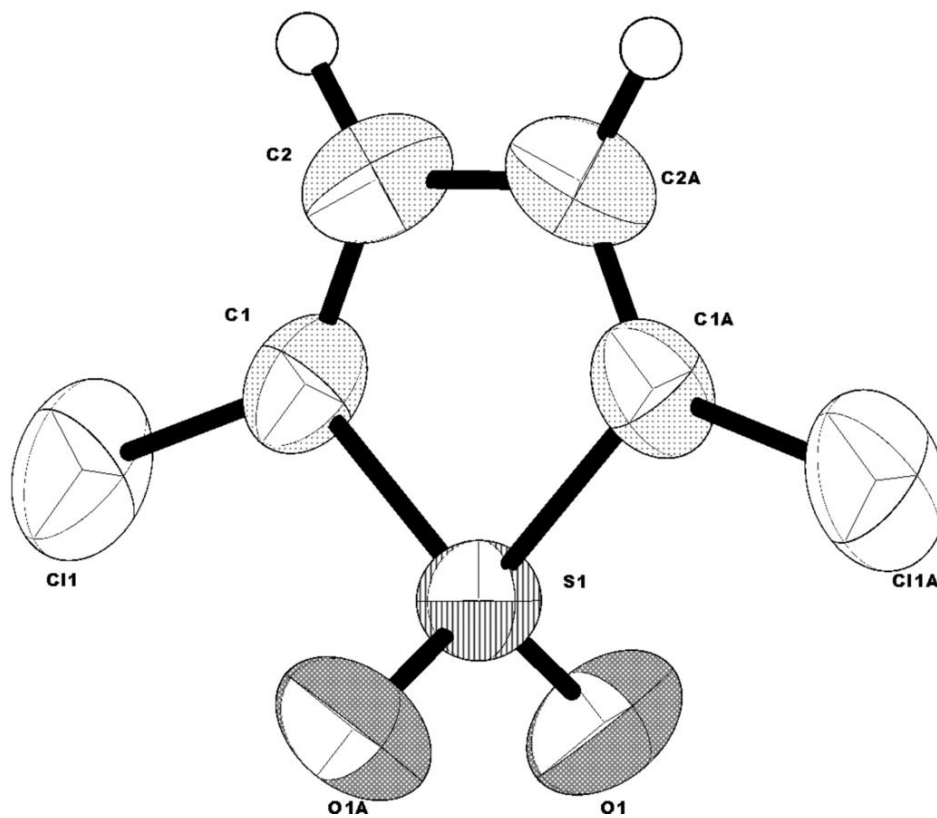




Fig. 2

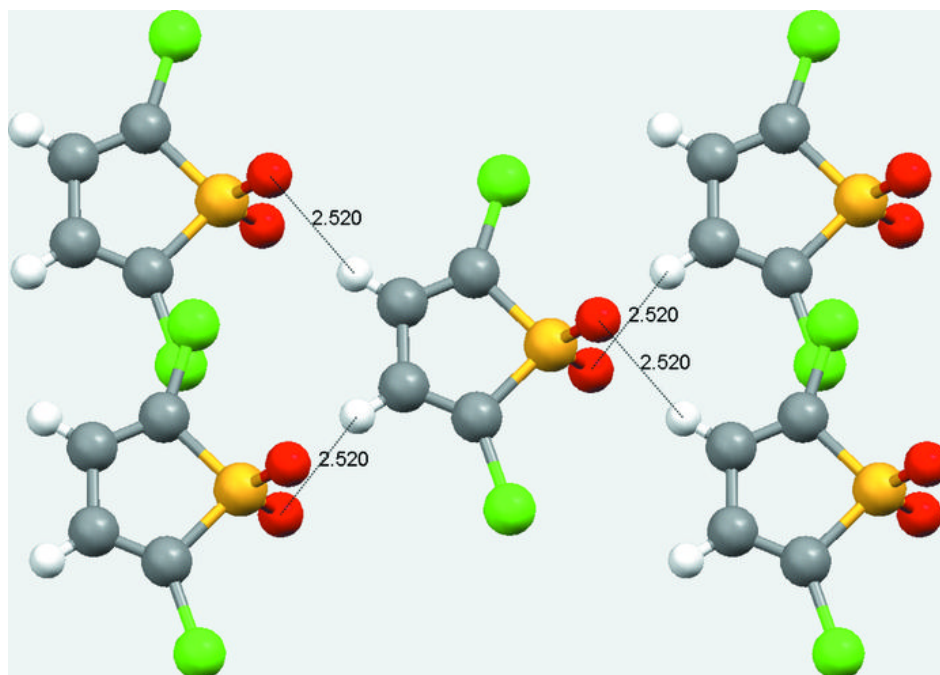


Fig. 3

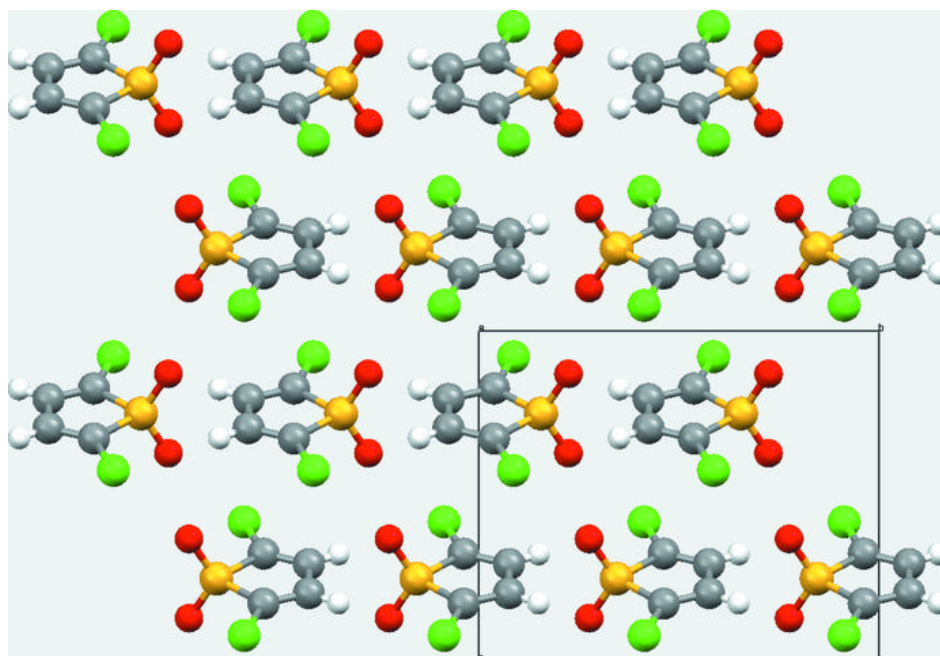


Fig. 4

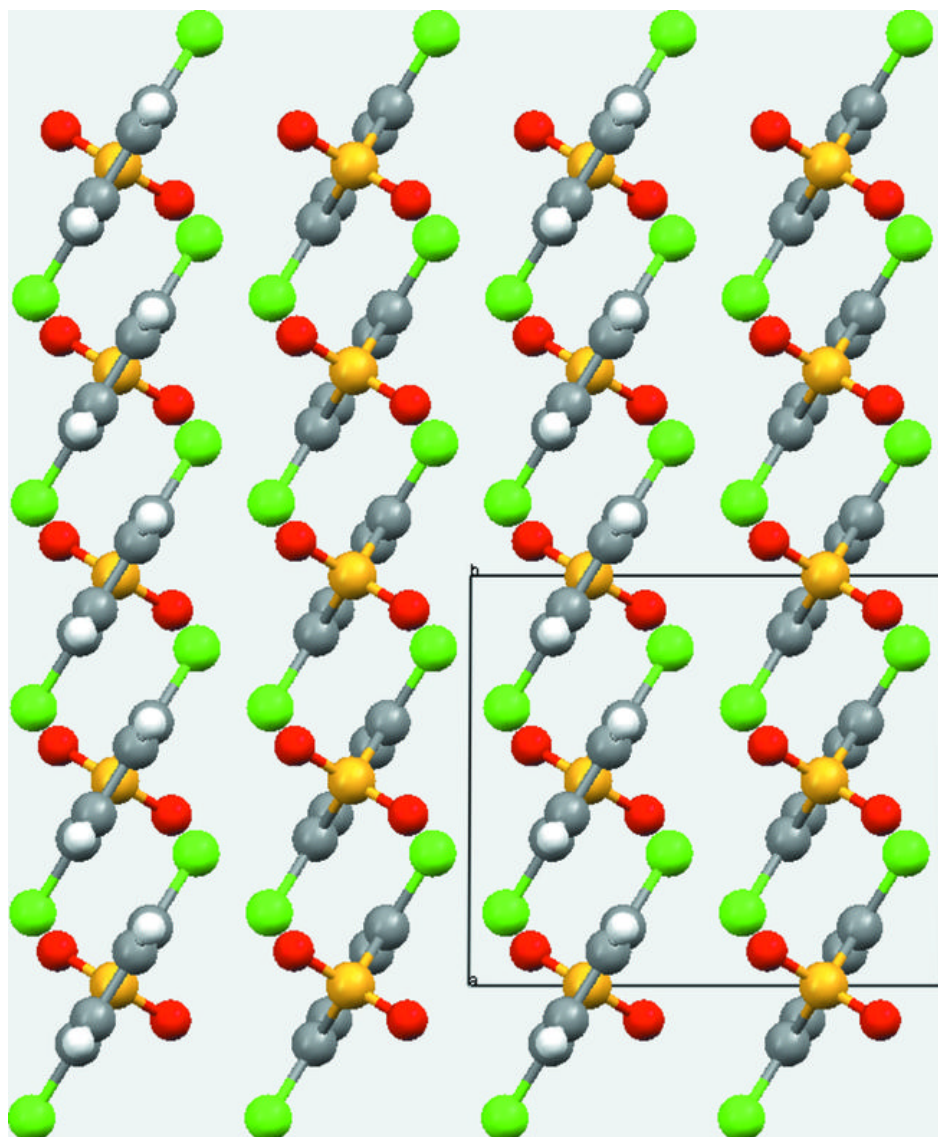


Fig. 5

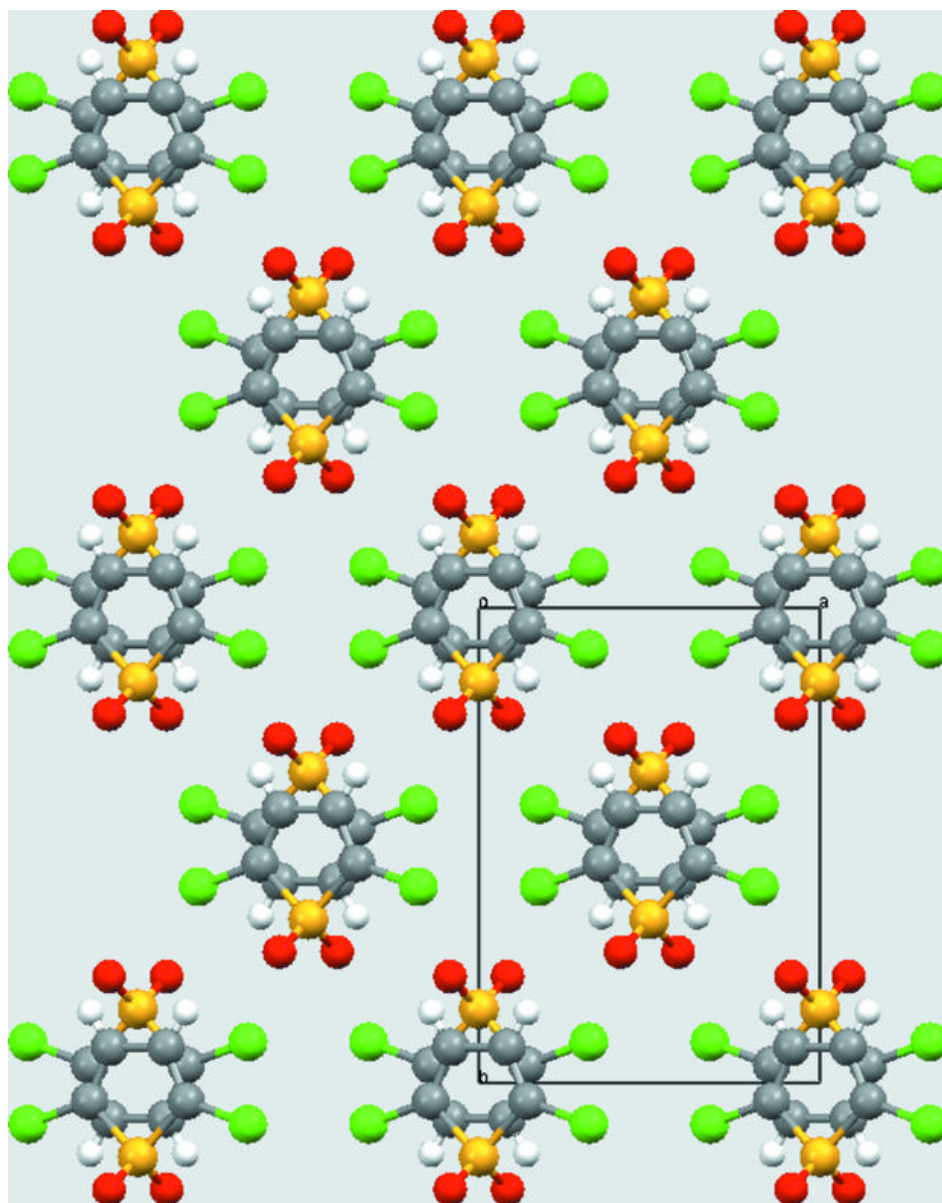


Fig. 6

